

Search Notes

Application/Control No.

10/799,670

Examiner

/BINH K. TIEU/

Applicant(s)/Patent under
Reexamination

HANDA, TOMOHISA

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	142.01	2/15/2008	BKT
	142.04		
	142.06		
	142.07		
	142.15		
	142.17		
	198		
	231-234		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST DATABASES SEARCH	2/14/2008	BKT